Form PTO 1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO. 10/567,027			
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				FILING DATE		GROUP			
				July 25, 2006		2629			
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE			
	AA	US 7,196,688 B2	3/27/2007	Bruce M. Schena					
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO			
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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